# Versuch 4: Transistor

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#### Introduction 1

In this experiment we examined the properties of a bipolar transistor in combination with an emitter circuit. Therby we measured the characteristic curve of the transistor and tested different konfigurations of the emittercircuit.

#### 2 Theorie

## small signal model

For small deviations around the workingpoint one can use the small signal modell leading to the following equation.

$$\begin{pmatrix} dI_{\rm B} \\ dI_{\rm C} \end{pmatrix} = \begin{pmatrix} \frac{1}{r_{\rm BE}} & S_{\rm r} \\ S & \frac{1}{r_{\rm CE}} \end{pmatrix} \begin{pmatrix} dU_{\rm BE} \\ dU_{\rm CE} \end{pmatrix}$$
(1)

whereby  $r_{\rm BE}$ ,  $r_{\rm CE}$  and the steepness S can be calculated with

$$\frac{1}{r_{\rm BE}} = \frac{\partial I_{\rm B}}{\partial U_{\rm BE}}|_{U_{\rm CE}} \tag{2}$$

$$\frac{1}{r_{\rm CE}} = \frac{\partial I_{\rm C}}{\partial U_{\rm CE}} |_{U_{\rm BE}} \tag{3}$$

$$\frac{1}{r_{\rm CE}} = \frac{\partial I_{\rm C}}{\partial U_{\rm CE}}|_{U_{\rm BE}}$$

$$S = \frac{\partial I_{\rm C}}{\partial U_{\rm BE}}\Big|_{U_{\rm CE}} = \frac{qI_{\rm C}}{k_{\rm B}T}$$
(4)

In addition to that  $I_{\rm B}$  can be calculated the following proportionality

$$I_{\rm B} \propto \exp\left(\frac{qU_{\rm BE}}{k_{\rm B}T}\right)$$
 (5)

#### 3 execution

#### 3.1 workingpoint

A bipolar transistor has a specific basevoltage range (the so called workingpoint) in wich it behaves approxmately linear. This workingpoint is tuned by setting the resistance at the potentiometer  $R_{12}$  1[see circuit diagram] to a point whereby the output amplitude  $u_a$  is maximal and the signal is not distorted. To tune the workingpoint, the loadresistor  $R_L$  was removed and a sinusoidal frequency of 5.5 kHz was applied.  $U_{\rm BE}$ ,  $U_{\rm CE}$ ,  $I_{\rm C}$  where measured with varying  $R_{\rm C}$  for further evaluation.

#### 3.2 Amplification of the emittercircuit

To further examine the emittercircuit 1[see circuit diagram] the amplidude quotionet  $u_a/u_e$  was measured for varying  $R_{\rm C}$  in different circuit configurations:

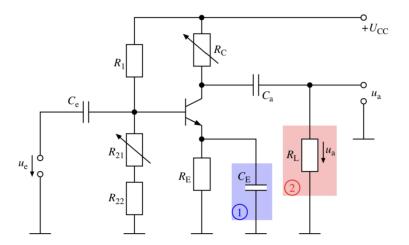


Abbildung 1: emittercircuit:

 $R_1=47$  kΩ,  $R_{22}=100$  Ω,  $R_E=10$  kΩ,  $C_e=47$  μF,  $C_a=470$  μF,  $U_{CC}=9$  V  $R_{12}$ : potentiometer for the workingpoint,  $R_C$ : potentiometer 0 - 10 kΩ,  $u_e$ : inputvoltage,  $u_a$ : outputvoltage

1. with capacitor CE but without resistor  $R_L$  2. without capacitor CE and without resistor  $R_L$  3. with capacitor CE and resistor  $R_L$ 

## 3.3 Frequency response

In this experiment the input frequency was varied from 6 Hz - 250 kHz to measure the phaseshift and the amplidude quotionet  $u_a/u_e$ . Therby circuit 1 with an collectorresistor of  $R_{\rm C}$  was used. In addition to that the oszilloscope was changed to x-y mode to observe lissajous curves.

## 3.4 characteristic curve

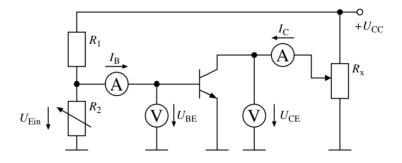


Abbildung 2: characteristic curve $R_1 = 1 \text{ k}\Omega$ ,  $R_2 = 220 \Omega$ 

To measure the characteristic curve of the transistor the circuit was change as shown in the circuit diagram 2. First the entry curve  $I_{\rm B}=f(U_{\rm BE})|_{U_{\rm CE}}$  was taken by changing  $U_{\rm BE}$  from 0 to 670 mV and measuring  $I_{\rm B}$ ,  $U_{\rm BE}$  and  $U_{\rm CE}$  with multimeters according to the scematic 2. Therby  $U_{\rm CE}$  was dialed in to match the results from experiment 1 4.2 with  $R_{\rm C}=5~{\rm k}\Omega$ . Afterwards the output characteristic curve  $I_{\rm C}=f(U_{\rm CE})|_{U_{\rm BE}}$  was recorded with a varying  $U_{\rm CE}$  from 1 - 10 V by measuring  $I_{\rm C}$ ,  $U_{\rm BE}$  and  $U_{\rm CE}$ . This curve was measured in both directions to observe the effect of heat on the transistor.

## 4 Evaluation and results

## 4.1 preliminary considerations

## 4.2 characteristic curve (Assignment 7)

As shown in table 4.2 some basevalues where recorded wich were needed in following experiments. They seem to be in a reasonable range.

$R_{\rm C}$ in ${\rm k}\Omega$	$U_{ m BE}$ in V	$U_{\rm CE}$ in V	$I_{ m C}$ in mA	$S \text{ in } 1/\Omega$
1	0,57	7,86	0,58	0.025
5	0,57	5,53	0,58	0.025
10	0,57	3,22	0,58	0.025

Tabelle 1: Basevalues

The characteristic input curve is plottet in figure 3. With the slope from the tangent one can calculate the baseresistance  $r_{\rm BE}=3.92~{\rm k}\Omega$  with equation 2. The operating temperature  $T=272.2~{\rm K}$  can be obtained by using the fitparameters from the exponetial fit and equation 5. Althoug the operating temperature has the correct magnitude it schould be at least 30 K higher. With this operating temperature and equation 4 the steepness S can be calculated as shown in figure 4.2.

The characteristic output curve is plottet in figure 4.

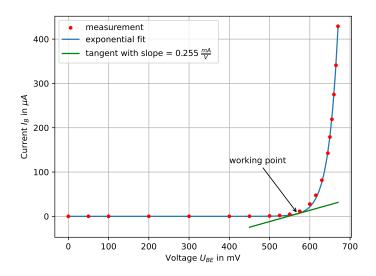


Abbildung 3: Characteristic curve from the input

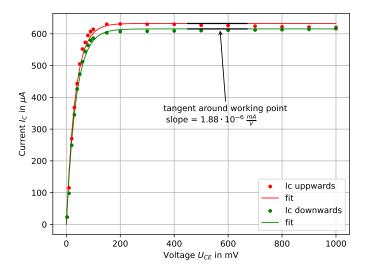


Abbildung 4: Characteristic curve from the output